

Reg No.: \_\_\_\_\_

Name: \_\_\_\_\_

**APJ ABDUL KALAM TECHNOLOGICAL UNIVERSITY**

B.Tech Degree S3 (R) (FT/WP) Examination November 2025 (2024 Scheme)

**Course Code: PCECT302****Course Name: SOLID STATE DEVICES**

Max. Marks: 60

Duration: 2 hours 30 minutes

**PART A***(Answer all questions. Each question carries 3 marks)*

CO Marks

- |   |   |     |     |
|---|---|-----|-----|
| 1 | Distinguish between lattice scattering and ionized impurity scattering  | CO2 | (3) |
| 2 | For a semiconductor under thermal equilibrium, effective densities of states in the conduction band and valence bands are given as $N_c = 10^{19} \text{cm}^{-3}$ and $N_v = 5 \times 10^{18} \text{cm}^{-3}$ , Energy band gap is 2 eV. Calculate the intrinsic carrier concentration at 300K. | CO1 | (3) |
| 3 | Define base width modulation and its impact on collector and base currents  | CO3 | (3) |
| 4 | Draw and explain current components in a p-n-p transistor   | CO3 | (3) |
| 5 | Distinguish between electron affinity and work function   | CO4 | (3) |
| 6 | Differentiate Ohmic and rectifying contacts   | CO4 | (3) |
| 7 | Define Sub threshold conduction in MOSFET   | CO5 | (3) |
| 8 | Explain the need for scaling?   | CO5 | (3) |

**PART B***(Answer any one full question from each module, each question carries 9 marks)***Module -1**

- |   |   |     |   |
|---|---|-----|---|
| 9 | a) Illustrate the Generation and recombination mechanisms of excess carriers in semiconductors.   | CO1 | 6 |
|   | b) An n-type Si sample with $N_D = 10^{15} \text{cm}^{-3}$ is steadily illuminated such that $g_{op} = 10^{21} \text{EHP/cm}^3\text{s}$ . If $\tau_n = \tau_p = 1 \mu\text{s}$ for this excitation, calculate the separation in the quasi-Fermi levels ( $E_{Fn} - E_{Fp}$ ). | CO1 | 3 |

- 10 a) Derive the expression for diffusion current density with suitable sketch. CO2 9

### Module -2

- 11 a) Derive the expression for the built-in potential of a PN junction under thermal equilibrium. CO3 5
- b) An abrupt silicon PN junction has  $N_A=10^{17} \text{ cm}^{-3}$  on the p-side and  $N_D=10^{15} \text{ cm}^{-3}$  on the n-side. The relative permittivity of Si is 11.8. CO3 4
1. Calculate the built-in voltage ( $V_0$ ).
  2. Width of depletion region (W)

- 12 a) Derive the ideal diode equation with a neat sketch. CO3 9

### Module -3

- 13 a) Draw and explain the C-V Characteristics of an Ideal MOS capacitor CO4 6
- b) Derive the expression for the threshold voltage of MOS Capacitor. CO4 3
- 14 a) Draw and explain the energy band diagrams, of an ideal MOS capacitor under equilibrium, and inversion conditions. CO4 5
- b) An nMOS transistor has  $W/L= 4/2$ , gate oxide thickness  $40 \text{ \AA}$ , Mobility of electrons  $180 \text{ cm}^2/\text{Vsec}$ . The threshold voltage is  $0.4 \text{ V}$ , relative permittivity of gate oxide  $\epsilon_{ox}=3.9$ . Calculate the drain current when
- i)  $V_{gs} = 1.5 \text{ V}$ ,  $V_{ds} = 1.8 \text{ V}$
  - ii)  $V_{gs} = 1.5 \text{ V}$ ,  $V_{ds} = 0.3 \text{ V}$

### Module -4

- 15 a) Explain drain induced barrier lowering CO5 3
- b) Distinguish between constant voltage scaling and constant field scaling CO5 6
- 16 a) Draw and explain the structure and working of Fin FET. CO5 6
- b) Explain channel length modulation of MOSFET CO5 3

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